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Responsible committee: NTI/1 Nanotechnologies

Interested committees:

Title: Draft BS IEC 62607-4-7 Ed1.0 Nanomanufacturing - Key control characteristics. Part 4-7: Anode nano-materials for nano-enabled electrical energy storage - Determination of magnetic impurities, ICP-OES method.

Please notify the secretary if you are aware of any keywords that might assist in classifying or identifying the standard or if the content of this standard

- i) has any issues related to 3rd party IPR, patent or copyright
- ii) affects other national standard(s)
- iii) requires additional national guidance or information

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Introduction

This draft standard is based on international discussions in which the UK has taken an active part. Your comments on this draft are welcome and will assist in the preparation of the consequent standard. There is a high probability that this text could be adopted by CENELEC as a reference document for harmonization or as a European Standard. Recipients of this draft are requested to comment on the text bearing in mind this possibility.

UK Vote

Please indicate whether you consider the UK should submit a negative (with reasons) or positive vote on this draft.

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Template for comments and secretariat observations

Date: xx/xx/20xx	Document: ISO/DIS xxxx
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1	2	(3)	4	5	(6)	7
MB	Clause No./ Subclause No./Annex (e.g. 3.1)	Paragraph/Figure/ Table/Note	Type of comment	Comment (justification for change) by the MB	Proposed change by the MB	Secretariat observations on each comment submitted
	3.1	Definition 1	ed	Definition is ambiguous and needs clarifying.	Amend to read '...so that the mains connector to which no connection...'	
	6.4	Paragraph 2	te	The use of the UV photometer as an alternative cannot be supported as serious problems have been encountered in its use in the UK.	Delete reference to UV photometer.	



113/372/CD

COMMITTEE DRAFT (CD)

PROJECT NUMBER:

IEC 62607-4-7 ED1

DATE OF CIRCULATION:

2017-07-21

CLOSING DATE FOR COMMENTS:

2017-10-13

SUPERSEDES DOCUMENTS:

113/341A/RVN, 113/354/CD

IEC TC 113 : NANOTECHNOLOGY FOR ELECTROTECHNICAL PRODUCTS AND SYSTEMS

SECRETARIAT:

Germany

SECRETARY:

Mr Norbert Fabricius

OF INTEREST TO THE FOLLOWING COMMITTEES:

SC 21A

PROPOSED HORIZONTAL STANDARD:

☐

Other TC/SCs are requested to indicate their interest, if any, in this CD to the secretary.

FUNCTIONS CONCERNED:

☐ EMC

☐ ENVIRONMENT

☐ QUALITY ASSURANCE

☐ SAFETY

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Recipients of this document are invited to submit, with their comments, notification of any relevant patent rights of which they are aware and to provide supporting documentation.

TITLE:

Nanomanufacturing - Key control characteristics - Part 4-7: Anode nanomaterials for nano-enabled electrical energy storage- Determination of magnetic impurities, ICP-OES method

NOTE FROM TC/SC OFFICERS:

This is the second CD following the discussions at the Tokyo meeting of TC 113.

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

NANOMANUFACTURING – KEY CONTROL CHARACTERISTICS–**Part 4-7: Anode nanomaterials for nano-enabled electrical energy storage– Determination of magnetic impurities, ICP-OES method****FOREWORD**

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International Standard IECXXXXX has been prepared by subcommittee XX: TITLE, of IEC technical committee XX:XXX.

The text of this standard is based on the following documents:

FDIS	Report on voting
XX/XX/FDIS	XX/XX/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- 122 • reconfirmed,
- 123 • withdrawn,
- 124 • replaced by a revised edition, or
- 125 • amended.

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127 The National Committees are requested to note that for this publication the stability date
128 is 20XX.

129 THIS TEXT IS INCLUDED FOR THE INFORMATION OF THE NATIONAL COMMITTEES AND WILL BE DELETED
130 AT THE PUBLICATION STAGE.

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